



FCC REPORT

Report Reference No.....	CHTEW19080018	Report verification:  Report No: CHTEW19080018
Project No.....	SHT1907066901EW	
FCC ID	2AT38M68	
Applicant's name	Ruggedmobi Co.,Limited	
Address.....	8B Jian'an-shanghai Center, 8000 Shennan Avenue, Futian District, Shenzhen, Guangdong, China	
Manufacturer.....	Ruggedmobi Co.,Limited	
Address.....	8B Jian'an-shanghai Center, 8000 Shennan Avenue, Futian District, Shenzhen, Guangdong, China	
Test item description	LTE Wireless Data Terminal	
Trade Mark	ruggedMOBI	
Model/Type reference.....	M68	
Listed Model(s)	-	
Standard	FCC CFR Title 47 Part 2 FCC CFR Title 47 Part 22 FCC CFR Title 47 Part 24 FCC CFR Title 47 Part 27	
Date of receipt of test sample.....	Jul 24, 2019	
Date of testing.....	Jul 25, 2019- Aug 06, 2019	
Date of issue.....	Aug 07, 2019	
Result.....	Pass	
Compiled by (position+printedname+signature)....	File administrators Silvia Li	
Supervised by (position+printedname+signature)....	Project Engineer Aaron Fang	
Approved by (position+printedname+signature)....	Manager Hans Hu	
Testing Laboratory Name	Shenzhen Huatongwei International Inspection Co., Ltd.	
Address.....	1/F, Bldg 3, Hongfa Hi-tech Industrial Park, Genyu Road, Tianliao, Gongming, Shenzhen, China	

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The test report merely correspond to the test sample.

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1. **TEST STANDARDS AND REPORT VERSION**

1.1. **Applicable Standards**

The tests were performed according to following standards:

[FCC Rules Part 2](#): FREQUENCY ALLOCATIONS AND RADIO TREATY MATTERS; GENERAL RULES AND REGULATIONS

[FCC Rules Part 22](#): PUBLIC MOBILE SERVICES

[FCC Rules Part 24](#): PERSONAL COMMUNICATIONS SERVICES

[FCC Rules Part 27](#): MISCELLANEOUS WIRELESS COMMUNICATIONS SERVICES

[ANSI C63.26: 2015](#): American National Standard for Compliance Testing of Transmitters Used in Licensed Radio Services

[KDB 971168 D01 Power Meas License Digital Systems v03](#): MEASUREMENT GUIDANCE FOR CERTIFICATION OF LICENSED DIGITAL TRANSMITTERS

1.2. **Report version information**

Revision No.	Date of issue	Description
N/A	2019-08-07	Original

2. Test Description

Test Item	Section in CFR 47	Result	Test Engineer
Conducted Output Power	Part 2.1046 Part 22.913(a) Part 24.232(c) Part 27.50	Pass	Jiongsheng Feng
Peak-to-Average Ratio	Part 24.232 Part 27.50	Pass	Jiongsheng Feng
99% Occupied Bandwidth & 26 dB Bandwidth	Part 2.1049 Part 22.917(b) Part 24.238(b) Part 27.53	Pass	Jiongsheng Feng
Band Edge	Part 2.1051 Part 22.917 Part 24.238 Part 27.53	Pass	Jiongsheng Feng
Conducted Spurious Emissions	Part 2.1051 Part 22.917 Part 24.238 Part 27.53	Pass	Jiongsheng Feng
Frequency stability VS Temperature	Part 2.1055(a)(1)(b) Part 22.355 Part 24.235 Part 27.54	Pass	Jiongsheng Feng
Frequency stability VS Voltage	Part 2.1055(d)(1)(2) Part 22.355 Part 24.235 Part 27.54	Pass	Jiongsheng Feng
ERP and EIRP	Part 22.913(a) Part 24.232(b) Part 27.50	Pass	Pan Xie
Radiated Spurious Emissions	Part 2.1053 Part 22.917 Part 24.238 Part 27.53	Pass	Pan Xie

Note: The measurement uncertainty is not included in the test result.

3. SUMMARY

3.1. Client Information

Applicant:	Ruggedmobi Co.,Limited
Address:	8B Jian'an-shanhai Center, 8000 Shennan Avenue, Futian District, Shenzhen, Guangdong, China
Manufacturer:	Ruggedmobi Co.,Limited
Address:	8B Jian'an-shanhai Center, 8000 Shennan Avenue, Futian District, Shenzhen, Guangdong, China

3.2. Product Description

Name of EUT:	LTE Wireless Data Terminal
Trade Mark:	ruggedMOBI
Model No.:	M68
Listed Model(s):	-
IMEI Code:	Conducted: 356234099817319 Radiated: 356234099816162
SIM Information:	Support Two SIM Card
Power supply:	DC 3.85V
Adapter information:	Model:HP-050200A1-VDE Input:100-240V a.c., 50/60Hz, 0.3A max Output:5.0V d.c., 2000mA
Hardware version:	6FF511_V2.00
Software version:	msm8953_64-userdebug 7.1.2 N2G47H 132 test-keys

4G

Operation Band:	<input checked="" type="checkbox"/> FDD Band 2	<input checked="" type="checkbox"/> FDD Band 4	<input checked="" type="checkbox"/> FDD Band 17
Transmit frequency:	FDD Band 2: 1850.7 MHz – 1909.3 MHz FDD Band 4: 1710.7 MHz – 1754.3 MHz FDD Band 17: 706.5 MHz – 713.5 MHz		
Receive frequency:	FDD Band 2: 1930.7 MHz – 1989.3 MHz FDD Band 4: 2110.7 MHz – 2154.3 MHz FDD Band 17: 736.5 MHz – 743.5 MHz		
Channel bandwidth:	FDD Band 2: 1.4MHz, 3MHz, 5MHz, 10MHz, 15MHz, 20MHz FDD Band 4: 1.4MHz, 3MHz, 5MHz, 10MHz, 15MHz, 20MHz FDD Band 17: 5MHz, 10MHz		
Power Class:	Class 3		
Modulation type:	QPSK, 16QAM		
Antenna type	FPC Antenna		
Antenna Gain	Band2:-1.4dBi Band4:-3.79dBi Band17:-0.96dBi		

3.3. Operation state

➤ Test frequency list

FDD Band 2		Test Frequency ID	Bandwidth [MHz]	N _{UL}	Frequency of Uplink [MHz]	N _{DL}	Frequency of Downlink [MHz]
Low Range	1.4	1.4	18607	1850.7	607	1930.7	
		3	18615	1851.5	615	1931.5	
		5	18625	1852.5	625	1932.5	
		10	18650	1855	650	1935	
		15 ^{1U}	18675	1857.5	675	1937.5	
		20 ^{1U}	18700	1860	700	1940	
	Mid Range	1.4/3/5/10 15 ^{1U} /20 ^{1U}	18900	1880	900	1960	
		1.4	19193	1909.3	1193	1989.3	
		3	19185	1908.5	1185	1988.5	
		5	19175	1907.5	1175	1987.5	
	High Range	10	19150	1905	1150	1985	
		15 ^{1U}	19125	1902.5	1125	1982.5	
		20 ^{1U}	19100	1900	1100	1980	
		NOTE 1: Bandwidth for which a relaxation of the specified UE receiver sensitivity requirement (TS 36.101 [27] Clause 7.3) is allowed.					
FDD Band 4		Test Frequency ID	Bandwidth [MHz]	N _{UL}	Frequency of Uplink [MHz]	N _{DL}	Frequency of Downlink [MHz]
Low Range	1.4	1.4	19957	1710.7	1957	2110.7	
		3	19965	1711.5	1965	2111.5	
		5	19975	1712.5	1975	2112.5	
		10	20000	1715	2000	2115	
		15	20025	1717.5	2025	2117.5	
		20	20050	1720	2050	2120	
	Mid Range	1.4/3/5/10/15/20	20175	1732.5	2175	2132.5	
		1.4	20393	1754.3	2393	2154.3	
		3	20385	1753.5	2385	2153.5	
		5	20375	1752.5	2375	2152.5	
	High Range	10	20350	1750	2350	2150	
		15	20325	1747.5	2325	2147.5	
		20	20300	1745	2300	2145	
		NOTE 1: Bandwidth for which a relaxation of the specified UE receiver sensitivity requirement (TS 36.101 [27] Clause 7.3) is allowed.					
FDD Band 17		Test Frequency ID	Bandwidth [MHz]	N _{UL}	Frequency of Uplink [MHz]	N _{DL}	Frequency of Downlink [MHz]
Low Range	5 ^{1U}	5 ^{1U}	23755	706.5	5755	736.5	
		10 ^{1U}	23780	709	5780	739	
	5 ^{1U} /10 ^{1U}	5 ^{1U} /10 ^{1U}	23790	710	5790	740	
		5 ^{1U}	23825	713.5	5825	743.5	
Mid Range	10 ^{1U}	10 ^{1U}	23800	711	5800	741	
		5 ^{1U}	23825	713.5	5825	743.5	
	5 ^{1U} /10 ^{1U}	5 ^{1U} /10 ^{1U}	23800	711	5800	741	
		5 ^{1U}	23825	713.5	5825	743.5	
		NOTE 1: Bandwidth for which a relaxation of the specified UE receiver sensitivity requirement (TS 36.101 [27] Clause 7.3) is allowed.					

3.4. EUT operation mode

For RF test items

The EUT has been tested under typical operating condition. Testing was performed by configuring EUT to maximum output power status.

The Test EUT support two SIM card(SIM1,SIM2),so all the tests are performed at each SIM card (SIM1,SIM2) mode, the datum recorded is the worst case for all the mode at SIM1 Card mode.

Test Items	Band	Bandwidth (MHz)						Modulation		RB #		
		1.4	3	5	10	15	20	QPSK	16QAM	1	Half	Full
Conducted Output Power	2	o	o	o	o	o	o	o	o	o	o	o
	4	o	o	o	o	o	o	o	o	o	o	o
	17	-	-	o	o	-	-	o	o	o	o	o
Peak-to-Average Ratio	2	o	o	o	o	o	o	o	o	o	-	o
	4	o	o	o	o	o	o	o	o	o	-	o
	17	-	-	o	o	-	-	o	o	o	-	o
99% Occupied Bandwidth & 26 dB Bandwidth	2	o	o	o	o	o	o	o	o	-	-	o
	4	o	o	o	o	o	o	o	o	-	-	o
	17	-	-	o	o	-	-	o	o	-	-	o
Band Edge	2	o	o	o	o	o	o	o	o	o	-	o
	4	o	o	o	o	o	o	o	o	o	-	o
	17	-	-	o	o	-	-	o	o	o	-	o
Conducted Spurious Emission	2	o	o	o	o	o	o	o	o	o	-	-
	4	o	o	o	o	o	o	o	o	o	-	-
	17	-	-	o	o	-	-	o	o	o	-	-
Frequency Stability	2	o	o	o	o	o	o	o	o	-	-	o
	4	o	o	o	o	o	o	o	o	-	-	o
	17	-	-	o	o	-	-	o	o	-	-	o
ERP and EIRP	2	o	o	o	o	o	o	o	o	o	-	-
	4	o	o	o	o	o	o	o	o	o	-	-
	17	-	-	o	o	-	-	o	o	o	-	-
Radiated Spurious Emission	2	o	o	o	o	o	o	o	-	o	-	-
	4	o	o	o	o	o	o	o	-	o	-	-
	17	--	-	o	o	-	-	o	-	o	-	-
Remark	1. The mark “o”means that this configuration is chosen for testing 2. The mark “-”means that this bandwidth is not test. 3. The device is investigated from 30MHz to 10 times of fundamental signal for radiated spurious emission test under different RB size/offset and modulations in exploratory test. Subsequently, only the worst case emissions are reported.											

3.5. EUT configuration

The following peripheral devices and interface cables were connected during the measurement:

- - supplied by the manufacturer
- - supplied by the lab

○	/	Manufacturer:	/
		Model No.:	/
○	/	Manufacturer:	/
		Model No.:	/

3.6. Modifications

No modifications were implemented to meet testing criteria.

4. **TEST ENVIRONMENT**

4.1. **Address of the test laboratory**

Laboratory: Shenzhen Huatongwei International Inspection Co., Ltd.

Address: 1/F, Bldg 3, Hongfa Hi-tech Industrial Park, Genyu Road, Tianliao, Gongming, Shenzhen, China

4.2. **Test Facility**

CNAS-Lab Code: L1225

Shenzhen Huatongwei International Inspection Co., Ltd. has been assessed and proved to be in compliance with CNAS-CL01 Accreditation Criteria for Testing and Calibration Laboratories (identical to ISO/IEC17025: 2005 General Requirements) for the Competence of Testing and Calibration Laboratories.

A2LA-Lab Cert. No.: 3902.01

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory has been accredited by A2LA for technical competence in the field of electrical testing, and proved to be in compliance with ISO/IEC 17025: 2005 General Requirements for the Competence of Testing and Calibration Laboratories and any additional program requirements in the identified field of testing.

FCC-Registration No.: 762235

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files.

IC-Registration No.:5377A

Two 3m Alternate Test Site of Shenzhen Huatongwei International Inspection Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No.: 5377A.

ACA

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory can also perform testing for the Australian C-Tick mark as a result of our A2LA accreditation.

4.3. Equipments Used during the Test

Used	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
●	Signal and spectrum Analyzer	R&S	FSV40	100048	2018/10/28	2019/10/27
●	Spectrum Analyzer	Agilent	N9020A	MY50510187	2018/09/29	2019/09/28
●	Radio communication tester	R&S	CMW500	137688-Lv	2018/09/29	2019/09/28
●	Test software	Tonscend	JS1120-1(LTE)	N/A	N/A	N/A
●	Test software	Tonscend	JS1120-2(WIFI)	N/A	N/A	N/A
●	Test software	Tonscend	JS1120-3(WCDMA)	N/A	N/A	N/A
●	Test software	Tonscend	JS1120-4(GSM)	N/A	N/A	N/A

● Radiated Spurious Emission						
Used	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
●	Semi-Anechoic Chamber	Albatross projects	SAC-3m-01	N/A	2018/09/30	2021/09/29
●	Spectrum Analyzer	R&S	FSP40	100597	2018/10/27	2019/10/26
●	Loop Antenna	R&S	HFH2-Z2	100020	2017/11/20	2020/11/19
●	Ultra-Broadband Antenna	SCHWARZBECK	VULB9163	538	2017/04/05	2020/04/04
●	Horn Antenna	SCHWARZBECK	9120D	1011	2017/04/01	2020/03/31
○	Horn Antenna	SCHWARZBECK	BBHA9170	25841	2017/03/27	2020/03/26
○	Pre-amplifier	BONN	BLWA0160-2M	1811887	2018/11/14	2019/11/13
●	Pre-amplifier	CD	PAP-0102	12004	2018/11/14	2019/11/13
●	Broadband Preamplifier	SCHWARZBECK	BBV 9718	9718-248	2019/04/26	2020/04/25
●	RF Connection Cable	HUBER+SUHNER	RE-7-FH	N/A	2018/11/15	2019/11/14
●	RF Connection Cable	HUBER+SUHNER	RE-7-FL	N/A	2018/11/15	2019/11/14
●	EMI Test Software	Audix	E3	N/A	N/A	N/A
●	Turntable	MATURO	TT2.0	N/A	N/A	N/A
●	Antenna Mast	MATURO	TAM-4.0-P	N/A	N/A	N/A

4.4. Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

Voltage	VN=Nominal Voltage	DC 3.85V
	VL=Lower Voltage	DC 3.60V
	VH=Higher Voltage	DC 4.40V
Temperature	TN=Normal Temperature	25 °C
	Extreme Temperature	From -30° to + 50° centigrade
Humidity	30~60 %	
Air Pressure	950-1050 hPa	

4.5. Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to TR-100028-01 "Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics;Part 1" and TR-100028-02 "Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics;Part 2" and is documented in the Shenzhen Huatongwei International Inspection Co., Ltd quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for Shenzhen Huatongwei laboratory is reported:

Test Items	Measurement Uncertainty	Notes
Transmitter power conducted	0.51 dB	(1)
Transmitter power Radiated	2.66dB for <1GHz 3.44dB for >1GHz	(1)
Conducted spurious emissions 9kHz~40GHz	0.51 dB	(1)
Radiated spurious emissions	2.66dB for <1GHz 3.44dB for >1GHz	(1)
Occupied Bandwidth	15Hz for <1GHz 70Hz for >1GHz	(1)
Frequency error	15Hz for <1GHz 70Hz for >1GHz	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=1.96$.

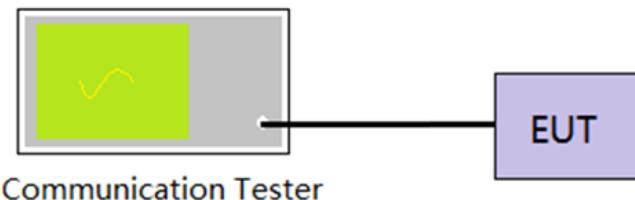
5. **TEST CONDITIONS AND RESULTS**

5.1. Conducted Output Power

LIMIT

N/A

TEST CONFIGURATION



TEST PROCEDURE

1. The EUT output port was connected to communication tester.
2. Set EUT at maximum power through communication tester.
3. Select lowest, middle, and highest channels for each band and different modulation.
4. Measure the maximum burst average power.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Passed Not Applicable

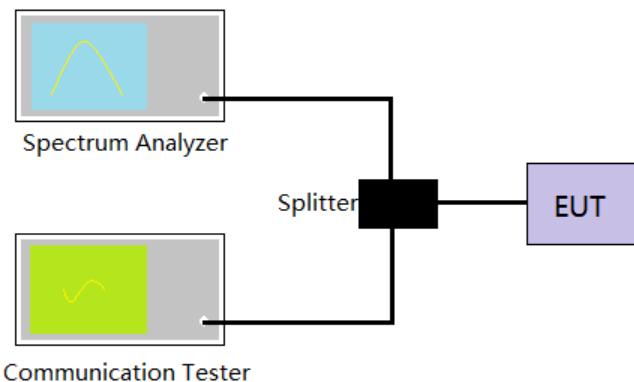
Refer to appendix A on the section 8 appendix report

5.2. Peak-to-Average Ratio

LIMIT

13dB

TEST CONFIGURATION



TEST PROCEDURE

1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
2. Set EUT in maximum power output.
3. Center Frequency = Carrier frequency, RBW > Emission bandwidth of signal
4. The signal analyzer was set to collect one million samples to generate the CCDF curve
5. The measurement interval was set depending on the type of signal analyzed.
 - i. For continuous signals (>98% duty cycle), the measurement interval was set to 1ms.
 - ii. For burst transmissions, the spectrum analyzer is set to use an internal “RF Burst” trigger that is synced with an incoming pulse and the measurement interval is set to less than the duration of the “on time” of one burst to ensure that energy is only captured during a time in which the transmitter is operating at maximum power
6. Record the maximum PAPR level associated with a probability of 0.1%.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Passed Not Applicable

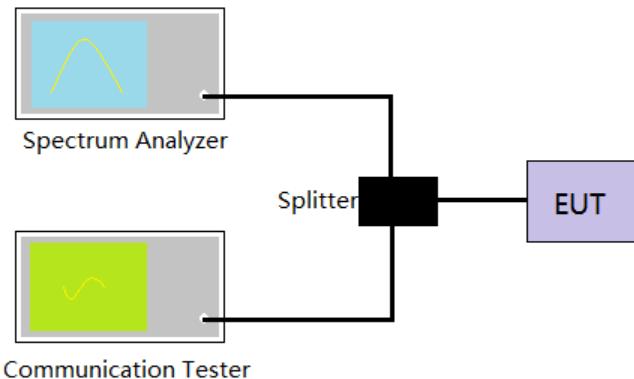
Refer to appendix B on the section 8 appendix report

5.3. 99% Occupied Bandwidth & 26 dB Bandwidth

LIMIT

N/A

TEST CONFIGURATION



TEST PROCEDURE

1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
2. Set EUT in maximum power output.
3. Spectrum analyzer setting as follow:
Center Frequency= Carrier frequency, RBW=1% to 5% of the anticipated OBW, VBW= 3 * RBW, Detector=Peak,
Trace maximum hold.
4. Record the value of 99% Occupied bandwidth and 26dB bandwidth.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Passed Not Applicable

Refer to appendix C on the section 8 appendix report

5.4. Band Edge

LIMIT

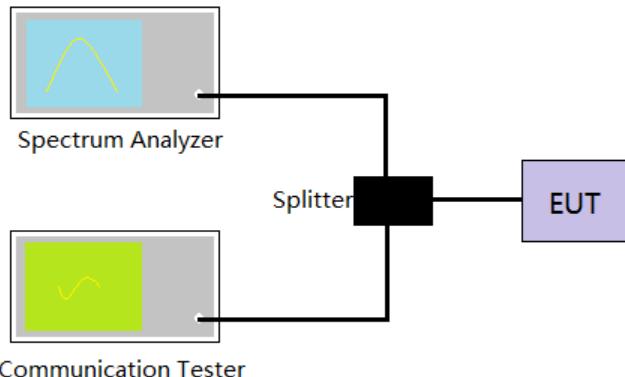
Part 24.238 and Part 22.917 and Part 27.53 specify that the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least $43 + 10 \log(P)$ dB.

The specification that emissions shall be attenuated below the transmitter power (P) by at least $43 + 10 \log(P)$ dB, translates in the relevant power range (1 to 0.001 W) to -13 dBm. At 1 W the specified minimum attenuation becomes 43 dB and relative to a 30 dBm (1 W) carrier becomes a limit of -13 dBm. At 0.001 W (0 dBm) the minimum attenuation is 13 dB, which again yields a limit of -13 dBm. In this way a translation of the specification from relative to absolute terms is carried out.

LTE Band 7

Part 27.53 m(4) For mobile digital stations, the attenuation factor shall be not less than $40 + 10 \log(P)$ dB on all frequencies between the channel edge and 5 megahertz from the channel edge, $43 + 10 \log(P)$ dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and $55 + 10 \log(P)$ dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section.

TEST CONFIGURATION



TEST PROCEDURE

1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
2. Set EUT in maximum power output.
3. The band edges of low and high channels were measured.
4. Spectrum analyzer setting as follow:
RBW= no less than 1% of the OBW, VBW =3 * RBW, Sweep time= Auto
5. Record the test plot.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Passed Not Applicable

Refer to appendix D on the section 8 appendix report

5.5. Conducted Spurious Emissions

LIMIT

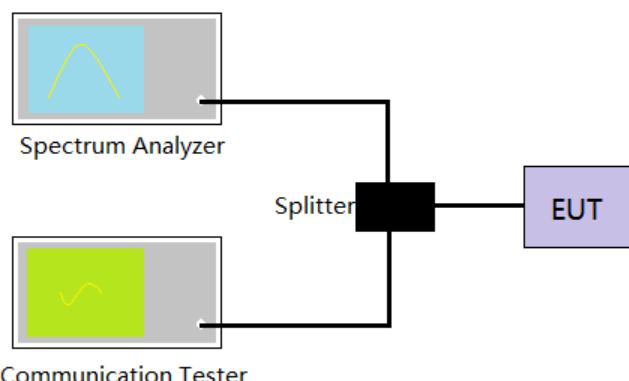
Part 24.238 and Part 22.917 and Part 27.53 specify that the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least $43 + 10 \log(P)$ dB.

The specification that emissions shall be attenuated below the transmitter power (P) by at least $43 + 10 \log(P)$ dB, translates in the relevant power range (1 to 0.001 W) to -13 dBm. At 1 W the specified minimum attenuation becomes 43 dB and relative to a 30 dBm (1 W) carrier becomes a limit of -13 dBm. At 0.001 W (0 dBm) the minimum attenuation is 13 dB, which again yields a limit of -13 dBm. In this way a translation of the specification from relative to absolute terms is carried out.

LTE Band 7

Part 27.53 m(4) For mobile digital stations, the attenuation factor shall be not less than $40 + 10 \log(P)$ dB on all frequencies between the channel edge and 5 megahertz from the channel edge, $43 + 10 \log(P)$ dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and $55 + 10 \log(P)$ dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section. In addition, the attenuation factor shall not be less than $43 + 10 \log(P)$ dB on all frequencies between 2490.5 MHz and 2496 MHz and $55 + 10 \log(P)$ dB at or below 2490.5 MHz. Mobile Satellite Service licensees operating on frequencies below 2495 MHz may also submit a documented interference complaint against BRS licensees operating on channel BRS Channel 1 on the same terms and conditions as adjacent channel BRS or EBS licensees. Limit <-25 dBm

TEST CONFIGURATION



TEST PROCEDURE

1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
2. Set EUT in maximum power output.
3. Spectrum analyzer setting as follow:
 - Below 1GHz, RBW=100KHz, VBW = 300KHz, Detector=Peak, Sweep time= Auto
 - Above 1GHz, RBW=1MHz, VBW=3MHz, Detector=Peak, Sweep time= Auto
 - Scan frequency range up to 10th harmonic.
4. Record the test plot.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Passed Not Applicable

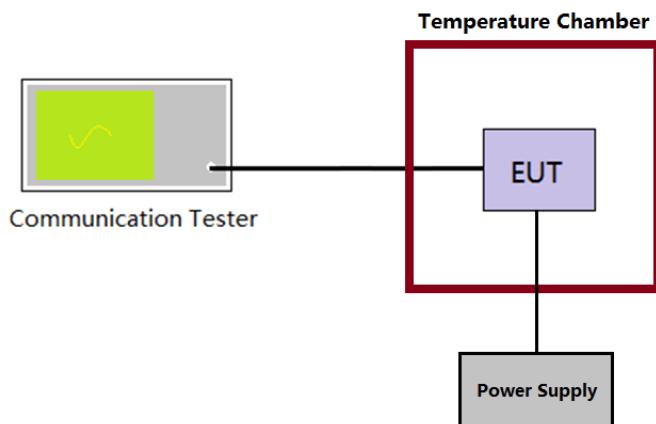
Refer to appendix E on the section 8 appendix report

5.6. Frequency stability VS Temperature measurement

LIMIT

2.5ppm

TEST CONFIGURATION



TEST PROCEDURE

1. The equipment under test was connected to an external DC power supply and input rated voltage.
2. The EUT output port was connected to communication tester.
3. The EUT was placed inside the temperature chamber.
4. Turn EUT off and set the chamber temperature to -30°C . After the temperature stabilized for approximately 30 minutes recorded the frequency.
5. Repeat step 4 measure with 10°C increased per stage until the highest temperature of $+50^{\circ}\text{C}$ reached.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Passed Not Applicable

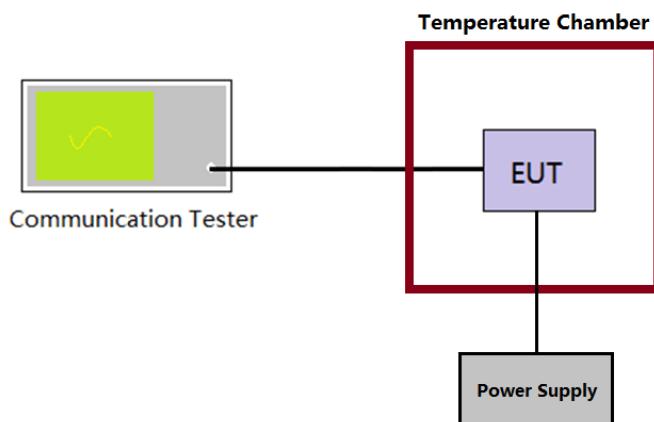
Refer to appendix F on the section 8 appendix report

5.7. Frequency stability VS Voltage measurement

LIMIT

2.5ppm

TEST CONFIGURATION



TEST PROCEDURE

1. The equipment under test was connected to an external DC power supply and input rated voltage.
2. The EUT output port was connected to communication tester.
3. The EUT was placed inside the temperature chamber at 25°C
4. The power supply voltage to the EUT was varied $\pm 15\%$ of the nominal value measured at the input to the EUT
5. Record the maximum frequency change.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Passed Not Applicable

Refer to appendix F on the section 8 appendix report

5.8. ERP and EIRP

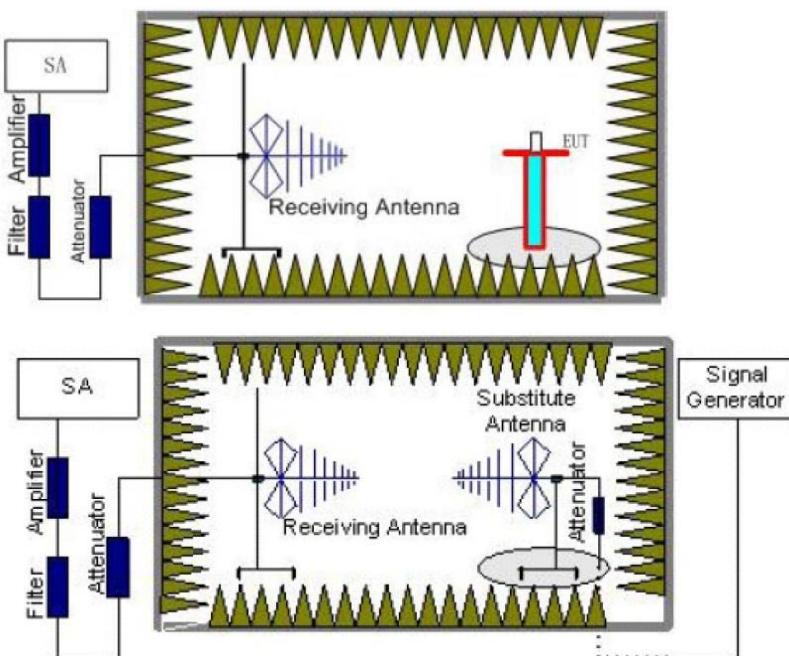
LIMIT

LTE Band 2: 2W(33dBm) EIRP

LTE Band 4: 1W(30dBm) EIRP

LTE Band 17: 3W(34.77dBm) ERP

TEST CONFIGURATION



TEST PROCEDURE

1. Place the EUT in the center of the turntable.
 - a) For radiated emissions measurements performed at frequencies less than or equal to 1 GHz, the EUT shall be placed on a RF-transparent table at a nominal height of 80 cm above the reference ground plane
 - b) For radiated measurements performed at frequencies above 1 GHz, the EUT shall be placed on an RF transparent table at a nominal height of 1.5 m above the ground plane.
2. Unless the EUT uses an integral antenna, the EUT shall be terminated with a non-radiating transmitter load. In cases where the EUT uses an adjustable antenna, the antenna shall be adjusted through typical positions and lengths to maximize emissions levels.
3. The EUT shall be tested while operating on the frequency per manufacturer specification. Set the transmitter to operate in continuous transmit mode.
4. Receiver or Spectrum set as follow:

Below 1GHz, RBW=100kHz, VBW=300kHz, Detector=Peak, Sweep time=Auto

Above 1GHz, RBW=1MHz, VBW=3MHz, Detector=Peak, Sweep time=Auto
5. Each emission under consideration shall be evaluated:
 - a) Raise and lower the measurement antenna from 1 m to 4 m, as necessary to enable detection of the maximum emission amplitude relative to measurement antenna height.
 - b) Rotate the EUT through 360° to determine the maximum emission level relative to the axial position.
 - c) Return the turntable to the azimuth where the highest emission amplitude level was observed.
 - d) Vary the measurement antenna height again through 1 m to 4 m again to find the height associated with the maximum emission amplitude.

- e) Record the measured emission amplitude level and frequency
6. Repeat step 5 for each emission frequency with the measurement antenna oriented in both the horizontal and vertical polarizations to determine the orientation that gives the maximum emissions amplitude.
7. Set-up the substitution measurement with the reference point of the substitution antenna located as near as possible to where the center of the EUT radiating element was located during the initial EUT measurement.
8. Maintain the previous measurement instrument settings and test set-up, with the exception that the EUT is removed and replaced by the substitution antenna.
9. Connect a signal generator to the substitution antenna; locate the signal generator so as to minimize any potential influences on the measurement results. Set the signal generator to the frequency where emissions are detected, and set an output power level such that the radiated signal can be detected by the measurement instrument, with sufficient dynamic range relative to the noise floor.
10. For each emission that was detected and measured in the initial test
 - a) Vary the measurement antenna height between 1 m to 4 m to maximize the received (measured) signal amplitude.
 - b) Adjust the signal generator output power level until the amplitude detected by the measurement instrument equals the amplitude level of the emission previously measured directly in step 5 and step 6.
 - c) Record the output power level of the signal generator when equivalence is achieved in step b).
11. Repeat step 8 through step 10 with the measurement antenna oriented in the opposite polarization.
12. Calculate the emission power in dBm referenced to a half-wave dipole using the following equation:
$$Pe = Ps(dBm) - \text{cable loss (dB)} + \text{antenna gain (dBd)}$$
where
Pe = equivalent emission power in dBm
Ps = source (signal generator) power in dBm
NOTE—dBd refers to the measured antenna gain in decibels relative to a half-wave dipole.
13. Correct the antenna gain of the substitution antenna if necessary to reference the emission power to a half-wave dipole. When using measurement antennas with the gain specified in dBi, the equivalent dipole-referenced gain can be determined from:
$$\text{gain (dBd)} = \text{gain (dBi)} - 2.15 \text{ dB.}$$
If necessary, the antenna gain can be calculated from calibrated antenna factor information
14. Provide the complete measurement results as a part of the test report.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Passed Not Applicable

LTE Band 2-1.4MHz					
Modulation	Channel	EIRP (dBm)		Limit (dBm)	Result
		Vertical	Horizontal		
QPSK	Low	20.25	17.88	≤33.00	PASS
	Mid	20.32	17.94		
	High	20.58	17.75		
16QAM	Low	19.91	17.55	≤33.00	PASS
	Mid	20.03	17.68		
	High	20.16	17.53		

LTE Band 2-3MHz					
Modulation	Channel	EIRP (dBm)		Limit (dBm)	Result
		Vertical	Horizontal		
QPSK	Low	20.37	17.81	≤33.00	PASS
	Mid	20.59	17.93		
	High	20.68	17.73		
16QAM	Low	19.81	17.61	≤33.00	PASS
	Mid	19.97	17.72		
	High	20.11	17.52		

LTE Band 2-5MHz					
Modulation	Channel	EIRP (dBm)		Limit (dBm)	Result
		Vertical	Horizontal		
QPSK	Low	20.97	18.17	≤33.00	PASS
	Mid	20.68	18.05		
	High	20.72	17.63		
16QAM	Low	19.82	17.71	≤33.00	PASS
	Mid	19.72	17.54		
	High	19.56	17.04		

LTE Band 2-10MHz					
Modulation	Channel	EIRP (dBm)		Limit (dBm)	Result
		Vertical	Horizontal		
QPSK	Low	20.91	17.95	≤33.00	PASS
	Mid	21.10	17.85		
	High	20.83	17.65		
16QAM	Low	19.71	17.40	≤33.00	PASS
	Mid	19.80	17.25		
	High	19.64	17.18		

LTE Band 2-15MHz					
Modulation	Channel	EIRP (dBm)		Limit (dBm)	Result
		Vertical	Horizontal		
QPSK	Low	20.23	18.37	≤33.00	PASS
	Mid	19.59	18.49		
	High	19.92	17.71		
16QAM	Low	18.99	17.57	≤33.00	PASS
	Mid	18.42	19.12		
	High	18.50	17.11		

LTE Band 2-20MHz					
Modulation	Channel	EIRP (dBm)		Limit (dBm)	Result
		Vertical	Horizontal		
QPSK	Low	20.32	17.87	≤33.00	PASS
	Mid	20.09	18.12		
	High	20.05	17.74		
16QAM	Low	18.86	17.54	≤33.00	PASS
	Mid	18.94	17.86		
	High	19.00	17.51		

LTE Band 4-1.4MHz					
Modulation	Channel	EIRP (dBm)		Limit (dBm)	Result
		Vertical	Horizontal		
QPSK	Low	20.62	18.59	≤30.00	PASS
	Mid	20.79	18.56		
	High	20.80	18.57		
16QAM	Low	20.01	18.35	≤30.00	PASS
	Mid	20.18	18.28		
	High	20.05	18.40		

LTE Band 4-3MHz					
Modulation	Channel	EIRP (dBm)		Limit (dBm)	Result
		Vertical	Horizontal		
QPSK	Low	21.54	19.25	≤30.00	PASS
	Mid	21.38	19.47		
	High	21.06	19.36		
16QAM	Low	21.22	19.18	≤30.00	PASS
	Mid	20.90	19.35		
	High	21.21	19.46		

LTE Band 4-5MHz					
Modulation	Channel	EIRP (dBm)		Limit (dBm)	Result
		Vertical	Horizontal		
QPSK	Low	21.74	20.29	≤30.00	PASS
	Mid	21.93	19.56		
	High	21.80	19.62		
16QAM	Low	20.78	19.70	≤30.00	PASS
	Mid	20.99	18.99		
	High	20.50	19.16		

LTE Band 4-10MHz					
Modulation	Channel	EIRP (dBm)		Limit (dBm)	Result
		Vertical	Horizontal		
QPSK	Low	21.99	20.18	≤30.00	PASS
	Mid	21.91	19.48		
	High	21.36	19.69		
16QAM	Low	21.18	19.65	≤30.00	PASS
	Mid	21.37	18.92		
	High	20.80	19.14		

LTE Band 4-15MHz					
Modulation	Channel	EIRP (dBm)		Limit (dBm)	Result
		Vertical	Horizontal		
QPSK	Low	20.79	18.20	≤30.00	PASS
	Mid	20.64	18.38		
	High	20.89	18.53		
16QAM	Low	20.35	17.97	≤30.00	PASS
	Mid	20.26	18.12		
	High	20.41	18.34		

LTE Band 4-20MHz					
Modulation	Channel	EIRP (dBm)		Limit (dBm)	Result
		Vertical	Horizontal		
QPSK	Low	20.87	18.21	≤30.00	PASS
	Mid	20.91	18.47		
	High	21.01	18.60		
16QAM	Low	20.31	17.96	≤30.00	PASS
	Mid	20.09	18.15		
	High	20.24	18.34		

LTE Band 17-5MHz					
Modulation	Channel	ERP (dBm)		Limit (dBm)	Result
		Vertical	Horizontal		
QPSK	Low	20.81	19.13	≤ 34.77	PASS
	Mid	20.79	18.81		
	High	21.64	19.16		
16QAM	Low	19.56	18.13	≤ 34.77	PASS
	Mid	19.63	18.01		
	High	20.01	18.18		

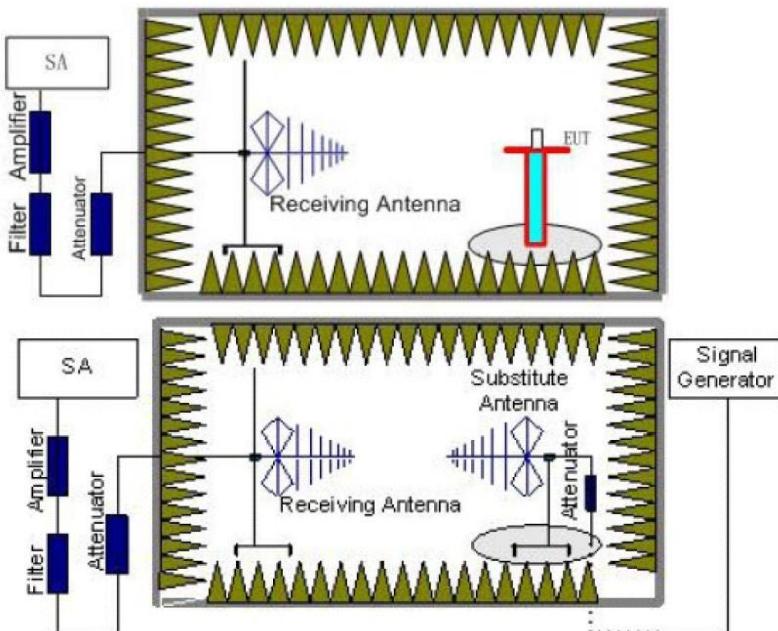
LTE Band 17-10MHz					
Modulation	Channel	ERP (dBm)		Limit (dBm)	Result
		Vertical	Horizontal		
QPSK	Low	21.10	18.97	≤ 34.77	PASS
	Mid	21.56	18.68		
	High	21.80	18.79		
16QAM	Low	19.41	18.40	≤ 34.77	PASS
	Mid	19.93	18.05		
	High	20.30	18.23		

5.9. Radiated Spurious Emission

LIMIT

LTE Band 2/4/17: -13dBm;

TEST CONFIGURATION



TEST PROCEDURE

1. Place the EUT in the center of the turntable.
 - a) For radiated emissions measurements performed at frequencies less than or equal to 1 GHz, the EUT shall be placed on a RF-transparent table at a nominal height of 80 cm above the reference ground plane
 - b) For radiated measurements performed at frequencies above 1 GHz, the EUT shall be placed on an RF transparent table at a nominal height of 1.5 m above the ground plane.
2. Unless the EUT uses an integral antenna, the EUT shall be terminated with a non-radiating transmitter load. In cases where the EUT uses an adjustable antenna, the antenna shall be adjusted through typical positions and lengths to maximize emissions levels.
3. The EUT shall be tested while operating on the frequency per manufacturer specification. Set the transmitter to operate in continuous transmit mode.
4. Receiver or Spectrum set as follow:

Below 1GHz, RBW=100kHz, VBW=300kHz, Detector=Peak, Sweep time=Auto

Above 1GHz, RBW=1MHz, VBW=3MHz, Detector=Peak, Sweep time=Auto
5. Each emission under consideration shall be evaluated:
 - a) Raise and lower the measurement antenna from 1 m to 4 m, as necessary to enable detection of the maximum emission amplitude relative to measurement antenna height.
 - b) Rotate the EUT through 360° to determine the maximum emission level relative to the axial position.
 - c) Return the turntable to the azimuth where the highest emission amplitude level was observed.
 - d) Vary the measurement antenna height again through 1 m to 4 m again to find the height associated with the maximum emission amplitude.
 - e) Record the measured emission amplitude level and frequency
6. Repeat step 5 for each emission frequency with the measurement antenna oriented in both the horizontal

and vertical polarizations to determine the orientation that gives the maximum emissions amplitude.

7. Set-up the substitution measurement with the reference point of the substitution antenna located as near as possible to where the center of the EUT radiating element was located during the initial EUT measurement.
8. Maintain the previous measurement instrument settings and test set-up, with the exception that the EUT is removed and replaced by the substitution antenna.
9. Connect a signal generator to the substitution antenna; locate the signal generator so as to minimize any potential influences on the measurement results. Set the signal generator to the frequency where emissions are detected, and set an output power level such that the radiated signal can be detected by the measurement instrument, with sufficient dynamic range relative to the noise floor.
10. For each emission that was detected and measured in the initial test
 - a) Vary the measurement antenna height between 1 m to 4 m to maximize the received (measured) signal amplitude.
 - b) Adjust the signal generator output power level until the amplitude detected by the measurement instrument equals the amplitude level of the emission previously measured directly in step 5 and step 6.
 - c) Record the output power level of the signal generator when equivalence is achieved in step b).
11. Repeat step 8 through step 10 with the measurement antenna oriented in the opposite polarization.
12. Calculate the emission power in dBm referenced to a half-wave dipole using the following equation:
$$Pe = Ps(dBm) - \text{cable loss (dB)} + \text{antenna gain (dBd)}$$
where
 Pe = equivalent emission power in dBm
 Ps = source (signal generator) power in dBm
NOTE—dBd refers to the measured antenna gain in decibels relative to a half-wave dipole.
13. Correct the antenna gain of the substitution antenna if necessary to reference the emission power to a half-wave dipole. When using measurement antennas with the gain specified in dBi, the equivalent dipole-referenced gain can be determined from:
$$\text{gain (dBd)} = \text{gain (dBi)} - 2.15 \text{ dB}.$$
If necessary, the antenna gain can be calculated from calibrated antenna factor information
14. Provide the complete measurement results as a part of the test report.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Passed

Not Applicable

LTE Band 2-1.4MHz					
Channel	Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
		Polarization	Level (dBm)		
Low	3701.4	Vertical	-45.17	≤-13.00	Pass
	5552.1	V	-43.66		
	7402.8	V	---		
	3701.4	Horizontal	-42.20	≤-13.00	Pass
	5552.1	H	-40.74		
	7402.8	H	---		
Mid	3760	Vertical	-44.67	≤-13.00	Pass
	5640	V	-43.76		
	7520	V	---		
	3760	Horizontal	-42.09	≤-13.00	Pass
	5640	H	-40.63		
	7520	H	---		
High	3818.6	Vertical	-44.86	≤-13.00	Pass
	5727.9	V	-43.93		
	7637.2	V	---		
	3818.6	Horizontal	-42.11	≤-13.00	Pass
	5727.9	H	-40.62		
	7637.2	H	---		

LTE Band 2-3MHz					
Channel	Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
		Polarization	Level (dBm)		
Low	3703	Vertical	-45.64	≤-13.00	Pass
	5554.5	V	-43.54		
	7406	V	---		
	3703	Horizontal	-46.19	≤-13.00	Pass
	5554.5	H	-43.43		
	7406	H	---		
Mid	3760	Vertical	-46.10	≤-13.00	Pass
	5640	V	-43.06		
	7520	V	---		
	3760	Horizontal	-45.95	≤-13.00	Pass
	5640	H	-42.53		
	7520	H	---		
High	3817	Vertical	-46.87	≤-13.00	Pass
	5725.5	V	-42.70		
	7634	V	---		
	3817	Horizontal	-46.33	≤-13.00	Pass
	5725.5	H	-42.59		
	7634	H	---		

LTE Band 2-5MHz					
Channel	Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
		Polarization	Level (dBm)		
Low	3705	Vertical	-46.03	≤-13.00	Pass
	5557.5	V	-43.43		
	7410	V	---		
	3705	Horizontal	-46.53	≤-13.00	Pass
	5557.5	H	-43.32		
	7410	H	---		
Mid	3760	Vertical	-46.45	≤-13.00	Pass
	5640	V	-42.98		
	7520	V	---		
	3760	Horizontal	-46.79	≤-13.00	Pass
	5640	H	-42.61		
	7520	H	---		
High	3815	Vertical	-47.44	≤-13.00	Pass
	5722.5	V	-42.73		
	7630	V	---		
	3815	Horizontal	-47.08	≤-13.00	Pass
	5722.5	H	-42.66		
	7630	H	---		

LTE Band 2-10MHz					
Channel	Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
		Polarization	Level (dBm)		
Low	3710	Vertical	-46.39	≤-13.00	Pass
	5565	V	-43.20		
	7420	V	---		
	3710	Horizontal	-47.41	≤-13.00	Pass
	5565	H	-42.99		
	7420	H	---		
Mid	3760	Vertical	-47.24	≤-13.00	Pass
	5640	V	-42.31		
	7520	V	---		
	3760	Horizontal	-47.92	≤-13.00	Pass
	5640	H	-41.15		
	7520	H	---		
High	3810	Vertical	-49.93	≤-13.00	Pass
	5715	V	-41.53		
	7620	V	---		
	3810	Horizontal	-49.17	≤-13.00	Pass
	5715	H	-41.37		
	7620	H	---		

LTE Band 2-15MHz					
Channel	Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
		Polarization	Level (dBm)		
Low	3715	Vertical	-47.11	≤-13.00	Pass
	5572.5	V	-43.07		
	7430	V	---		
	3715	Horizontal	-47.70	≤-13.00	Pass
	5572.5	H	-42.95		
	7430	H	---		
Mid	3760	Vertical	-47.60	≤-13.00	Pass
	5640	V	-42.56		
	7520	V	---		
	3760	Horizontal	-47.99	≤-13.00	Pass
	5640	H	-42.11		
	7520	H	---		
High	3805	Vertical	-48.76	≤-13.00	Pass
	5707.5	V	-42.26		
	7610	V	---		
	3805	Horizontal	-49.01	≤-13.00	Pass
	5707.5	H	-42.31		
	7610	H	---		
LTE Band 2-20MHz					
Channel	Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
		Polarization	Level (dBm)		
Low	3720	Vertical	-47.52	≤-13.00	Pass
	5580	V	-42.98		
	7440	V	---		
	3720	Horizontal	-47.94	≤-13.00	Pass
	5580	H	-42.89		
	7440	H	---		
Mid	3760	Vertical	-47.87	≤-13.00	Pass
	5640	V	-42.62		
	7520	V	---		
	3760	Horizontal	-48.15	≤-13.00	Pass
	5640	H	-42.32		
	7520	H	---		
High	3800	Vertical	-48.65	≤-13.00	Pass
	5700	V	-42.42		
	7600	V	---		
	3800	Horizontal	-48.36	≤-13.00	Pass
	5700	H	-42.36		
	7600	H	---		

Remark:

1. Remark"---" means that the emission level is too low to be measured
2. The emission levels of below 1 GHz are very lower than the limit and not show in test report.

LTE Band 4-1.4MHz					
Channel	Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
		Polarization	Level (dBm)		
Low	3421.4	Vertical	-41.15	≤-13.00	Pass
	5132.1	V	-42.68		
	6842.8	V	---		
	3421.4	Horizontal	-42.05	≤-13.00	Pass
	5132.1	H	-43.67		
	6842.8	H	---		
Mid	3465	Vertical	-41.23	≤-13.00	Pass
	5197.5	V	-42.60		
	6930	V	---		
	3465	Horizontal	-41.95	≤-13.00	Pass
	5197.5	H	-43.59		
	6930	H	---		
High	3508.6	Vertical	-41.36	≤-13.00	Pass
	5262.9	V	-42.73		
	7017.2	V	---		
	3508.6	Horizontal	-41.96	≤-13.00	Pass
	5262.9	H	-43.60		
	7017.2	H	---		

LTE Band 4-3MHz					
Channel	Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
		Polarization	Level (dBm)		
Low	3423	Vertical	-41.50	≤-13.00	Pass
	5134.5	V	-42.58		
	6846	V	---		
	3423	Horizontal	-41.85	≤-13.00	Pass
	5134.5	H	-43.57		
	6846	H	---		
Mid	3465	Vertical	-41.57	≤-13.00	Pass
	5197.5	V	-42.65		
	6930	V	---		
	3465	Horizontal	-41.68	≤-13.00	Pass
	5197.5	H	-43.71		
	6930	H	---		
High	3507	Vertical	-41.81	≤-13.00	Pass
	5260.5	V	-42.44		
	7014	V	---		
	3507	Horizontal	-41.57	≤-13.00	Pass
	5260.5	H	-43.82		
	7014	H	---		

LTE Band 4-5MHz					
Channel	Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
		Polarization	Level (dBm)		
Low	3425	Vertical	-41.83	≤-13.00	Pass
	5137.5	V	-42.46		
	6850	V	---		
	3425	Horizontal	-41.45	≤-13.00	Pass
	5137.5	H	-43.71		
	6850	H	---		
Mid	3465	Vertical	-41.91	≤-13.00	Pass
	5197.5	V	-42.54		
	6930	V	-		
	3465	Horizontal	-41.57	≤-13.00	Pass
	5197.5	H	-43.81		
	6930	H	---		
High	3505	Vertical	-41.74	≤-13.00	Pass
	5257.5	V	-42.39		
	7010	V	-		
	3505	Horizontal	-41.49	≤-13.00	Pass
	5257.5	H	-43.73		
	7010	H	---		

LTE Band 4-10MHz					
Channel	Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
		Polarization	Level (dBm)		
Low	3430	Vertical	-42.19	≤-13.00	Pass
	5145	V	-42.58		
	6860	V	---		
	3430	Horizontal	-41.45	≤-13.00	Pass
	5145	H	-43.71		
	6860	H	---		
Mid	3465	Vertical	-42.28	≤-13.00	Pass
	5197.5	V	-42.67		
	6930	V	---		
	3465	Horizontal	-41.58	≤-13.00	Pass
	5197.5	H	-43.81		
	6930	H	-		
High	3500	Vertical	-42.11	≤-13.00	Pass
	5250	V	-42.51		
	7000	V	-		
	3500	Horizontal	-41.41	≤-13.00	Pass
	5250	H	-43.66		
	7000	H	---		

LTE Band 4-15MHz					
Channel	Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
		Polarization	Level (dBm)		
Low	3435	Vertical	-41.81	≤-13.00	Pass
	5152.5	V	-42.44		
	6870	V	---		
	3435	Horizontal	-41.27	≤-13.00	Pass
	5152.5	H	-43.79		
	6870	H	---		
Mid	3465	Vertical	-41.70	≤-13.00	Pass
	5197.5	V	-42.35		
	6930	V	---		
	3465	Horizontal	-41.42	≤-13.00	Pass
	5197.5	H	-43.90		
	6930	H	---		
High	3495	Vertical	-41.50	≤-13.00	Pass
	5242.5	V	-42.16		
	6990	V	---		
	3495	Horizontal	-41.36	≤-13.00	Pass
	5242.5	H	-43.85		
	6990	H	---		

LTE Band 4-20MHz					
Channel	Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
		Polarization	Level (dBm)		
Low	3440	Vertical	-42.25	≤-13.00	Pass
	5160	V	-41.91		
	6880	V	---		
	3440	Horizontal	-41.60	≤-13.00	Pass
	5160	H	-43.65		
	6880	H	---		
Mid	3465	Vertical	-42.43	≤-13.00	Pass
	5197.5	V	-42.10		
	6930	V	---		
	3465	Horizontal	-41.78	≤-13.00	Pass
	5197.5	H	-43.50		
	6930	H	---		
High	3490	Vertical	-42.17	≤-13.00	Pass
	5235	V	-43.41		
	6980	V	---		
	3490	Horizontal	-41.78	≤-13.00	Pass
	5235	H	-43.82		
	6980	H	---		

Remark:

1. Remark"---" means that the emission level is too low to be measured
2. The emission levels of below 1 GHz are very lower than the limit and not show in test report.

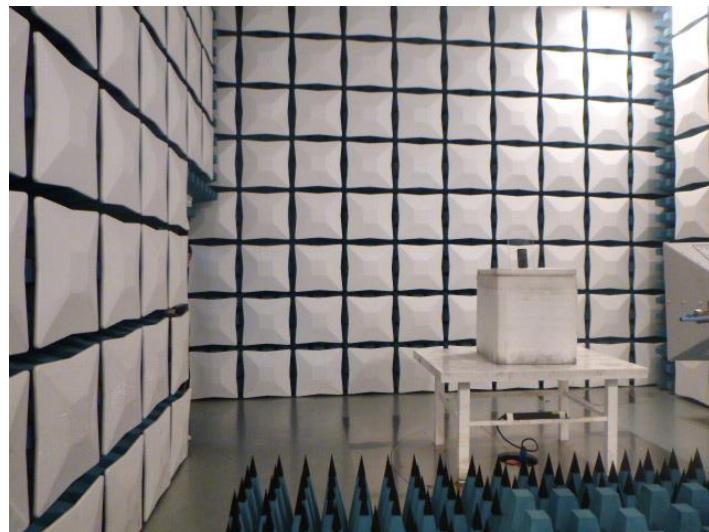
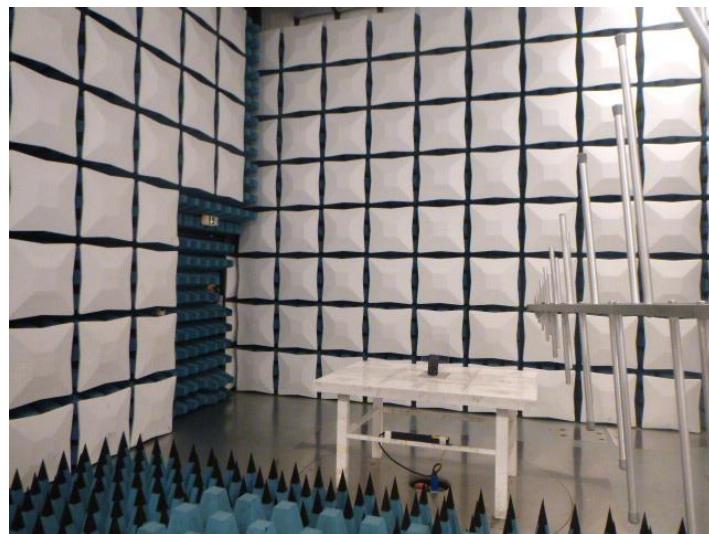
LTE Band 17-5MHz					
Channel	Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
		Polarization	Level (dBm)		
Low	1413	Vertical	-42.31	≤-13.00	Pass
	2119.5	V	-41.74		
	2826	V	---		
	1413	Horizontal	-42.60	≤-13.00	Pass
	2119.5	H	-43.12		
	2826	H	---		
Mid	1420	Vertical	-42.78	≤-13.00	Pass
	2130	V	-42.15		
	2840	V	---		
	1420	Horizontal	-42.05	≤-13.00	Pass
	2130	H	-42.58		
	2840	H	---		
High	1427	Vertical	-43.21	≤-13.00	Pass
	2140.5	V	-42.86		
	2854	V	---		
	1427	Horizontal	-41.93	≤-13.00	Pass
	2140.5	H	-42.88		
	2854	H	---		

LTE Band 17-10MHz					
Channel	Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
		Polarization	Level (dBm)		
Low	1418	Vertical	-42.41	≤-13.00	Pass
	2127	V	-41.64		
	2836	V	---		
	1418	Horizontal	-42.98	≤-13.00	Pass
	2127	H	-43.20		
	2836	H	---		
Mid	1420	Vertical	-42.71	≤-13.00	Pass
	2130	V	-41.91		
	2840	V	---		
	1420	Horizontal	-42.66	≤-13.00	Pass
	2130	H	-42.15		
	2840	H	---		
High	1422	Vertical	-42.95	≤-13.00	Pass
	2133	V	-42.31		
	2844	V	---		
	1422	Horizontal	-42.62	≤-13.00	Pass
	2133	H	-42.32		
	2844	H	---		

Remark:

1. Remark"---" means that the emission level is too low to be measured
2. The emission levels of below 1 GHz are very lower than the limit and not show in test report

6. TEST SETUP PHOTOS OF THE EUT



7. EXTERNAL AND INTERNAL PHOTOS OF THE EUT

Refere to the test report No.: CHTEW19080016

8. APPENDIX REPORT